

# 1-Mbit (128 K × 8) Serial SPI nvSRAM with Real Time Clock

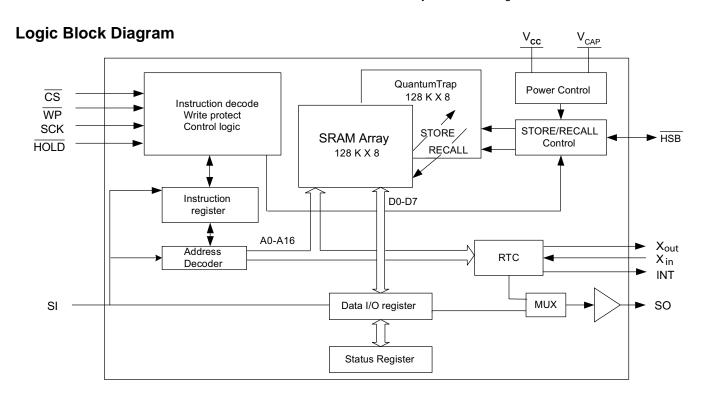
#### **Features**

- 1-Mbit nonvolatile static random access memory (nvSRAM)
  - □ Internally organized as 128 K x 8
  - □ STORE to QuantumTrap nonvolatile elements initiated <u>automatically</u> on power-down (AutoStore) or by user using HSB pin (Hardware STORE) or SPI instruction (Software STORE)
  - □ RECALL to SRAM initiated on power-up (Power-up RECALL) or by SPI instruction (Software RECALL)
  - □ Automatic STORE on power-down with a small capacitor
- High reliability
  - □ Infinite read, write, and RECALL cycles
  - ☐ 1 million STORE cycles to QuantumTrap
  - □ Data retention: 20 years
- Real time clock (RTC)
  - □ Full featured real time clock
  - Watchdog timer
  - Clock alarm with programmable interrupts
  - □ Capacitor or battery backup for RTC
  - □ Backup current of 0.35 µA (Typical)
- High speed serial peripheral interface (SPI)
  - □ 40 MHz clock rate SRAM memory access
  - □ 25 MHz clock rate RTC memory access
  - ☐ Supports SPI mode 0 (0,0) and mode 3 (1,1)

- Write protection
  - ☐ Hardware protection using Write Protect (WP) pin
  - □ Software protection using Write Disable instruction
  - ☐ Software block protection for 1/4, 1/2, or entire array
- Low power consumption
  - □ Single 3 V +20%, −10% operation
- ☐ Average active current of 10 mA at 40 MHz operation
- Industry standard configurations
  - □ Industrial temperature
  - □ 16-pin small outline integrated circuit (SOIC) package
  - □ Restriction of hazardous substances (RoHS) compliant

#### Overview

The Cypress CY14B101P combines a 1-Mbit nonvolatile static RAM with full featured real time clock in a monolithic integrated circuit with serial SPI interface. The memory is organized as 128 K words of 8 bits each. The embedded nonvolatile elements incorporate the QuantumTrap technology, creating the world's most reliable nonvolatile memory. The SRAM provides infinite read and write cycles, while the QuantumTrap cells provide highly reliable nonvolatile storage of data. Data transfers from SRAM to the nonvolatile elements (STORE operation) takes place automatically at power-down. On power-up, data is restored to the SRAM from the nonvolatile memory (RECALL operation). The STORE and RECALL operations can also be initiated by the user through SPI instruction.





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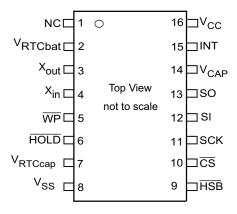
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### **Pinout**

Figure 1. 16-pin SOIC pinout



### **Pin Definitions**

Pin Name	I/O Type	Description
CS	Input	Chip select. Activates the device when pulled LOW. Driving this pin HIGH puts the device in low power standby mode.
SCK	Input	Serial clock. Runs at speeds up to maximum of f <sub>SCK</sub> . Serial input is latched at the rising edge of this clock. Serial output is driven at the falling edge of the clock.
SI	Input	Serial input. Pin for input of all SPI instructions and data.
SO	Output	Serial output. Pin for output of data through SPI.
WP	Input	Write protect. Implements hardware write protection in SPI.
HOLD	Input	HOLD pin. Suspends serial operation.
HSB	Input/Output	Hardware STORE busy: Output: Indicates busy status of nvSRAM when LOW. After each Hardware and Software STORE operation, HSB is driven HIGH for a short time (t <sub>HHHD</sub> ) with standard output high current and then a weak internal pull-up resistor keeps this pin HIGH (External pull-up resistor connection optional). Input: Hardware STORE implemented by pulling this pin LOW externally.
V <sub>CAP</sub>	Power supply	AutoStore Capacitor. Supplies power to the nvSRAM during power loss to STORE data from the SRAM to nonvolatile elements. If AutoStore is not needed, this pin must be left as No connect. It must never be connected to ground.
V <sub>RTCcap</sub> <sup>[1]</sup>	Power supply	Capacitor backup for RTC. Left unconnected if V <sub>RTCbat</sub> is used.
	Power supply	Battery backup for RTC. Left unconnected if V <sub>RTCcap</sub> is used.
Xout [1]	Output	Crystal output connection. Drives crystal on start up.
Xin <sup>[1]</sup>	Input	Crystal input connection. For 32.768 kHz crystal.
INT <sup>[1]</sup>	Output	Interrupt output. Programmable to respond to the clock alarm, the watchdog timer, and the power monitor. Also programmable to either active HIGH (push or pull) or LOW (open drain).
NC	No connect	No connect. This pin is not connected to the die.
V <sub>SS</sub>	Power supply	Ground
V <sub>CC</sub>	Power supply	Power Supply (2.7 V-3.6 V)

#### Note

Left unconnected if RTC feature is not used



#### **Device Operation**

CY14B101P is a 1-Mbit nvSRAM memory with integrated RTC and SPI interface. All the reads and writes to nvSRAM happen to the SRAM, which gives nvSRAM the unique capability to handle infinite writes to the memory. The data in SRAM is secured by a STORE sequence that transfers the data in parallel to the nonvolatile QuantumTrap cells. A small capacitor (V<sub>CAP</sub>) is used to AutoStore the SRAM data in nonvolatile cells when power goes down providing power-down data security. The QuantumTrap nonvolatile elements built in the reliable SONOS technology make nvSRAM the ideal choice for secure data storage.

In CY14B101P, the 1-Mbit memory array is organized as 128 K words × 8 bits. The memory is accessed through a standard SPI interface that enables very high clock speeds up to 40 MHz with zero cycle delay read and write cycles. CY14B101P supports SPI modes 0 and 3 (CPOL, CPHA = 0, 0 and 1, 1) and operates as SPI slave. The device is enabled using the Chip Select (CS) pin and accessed through Serial Input (SI), Serial Output (SO), and Serial Clock (SCK) pins.

CY14B101P provides the feature for hardware and software write protection through the WP pin and WRDI instruction. CY14B101P also provides mechanisms for block write protection (1/4, 1/2, or full array) using BP0 and BP1 pins in the Status Register. Further, the HOLD pin is used to suspend any serial communication without resetting the serial sequence.

CY14B101P uses the standard SPI opcodes for memory access. In addition to the general SPI instructions for read and write, CY14B101P provides four special instructions that enable access to four nvSRAM specific functions: STORE, RECALL, AutoStore Disable (ASDISB), and AutoStore Enable (ASENB).

The major benefit of serial (SPI) nvSRAM over serial EEPROMs is that all reads and writes to nvSRAM are performed at the speed of SPI bus with zero cycle delay. Therefore, no wait time is required after any of the memory accesses. The STORE and RECALL operations need finite time to complete and all memory accesses are inhibited during this time. While a STORE or RECALL operation is in progress, the busy status of the device is indicated by the Hardware STORE Busy (HSB) pin and also reflected on the RDY bit of the Status Register.

#### **SRAM Write**

All writes to nvSRAM are carried out on the SRAM and do not use up any endurance cycles of the nonvolatile memory. This enables the user to perform infinite write operations. A write cycle is performed through the WRITE instruction. The WRITE instruction is issued through the SI pin of the nvSRAM and consists of the WRITE opcode, 3 bytes of address, and 1 byte of data. Write to nvSRAM is done at SPI bus speed with zero cycle delay.

CY14B101P allows burst mode writes to be performed through SPI. This enables write operations on consecutive addresses without issuing a new WRITE instruction. When the last address in memory is reached in burst mode, the address rolls over to 0x0000 and the device continues to write.

The SPI write cycle sequence is defined in the memory access section of SPI protocol description.

#### **SRAM Read**

A read cycle in CY14B101P is performed at the SPI bus speed and the data is read out with zero cycle delay after the READ instruction is executed. The READ instruction is issued through the SI pin of the nvSRAM and consists of the READ opcode and 3 bytes of address. The data is read out on the SO pin.

CY14B101P enables burst mode reads to be performed through SPI. This enables reads on consecutive addresses without issuing a new READ instruction. When the last address in memory is reached in burst mode read, the address rolls over to 0x0000 and the device continues to read.

The SPI read cycle sequence is defined in the memory access section of SPI protocol description.

#### **STORE Operation**

STORE operation transfers the data from the SRAM to the nonvolatile QuantumTrap cells. The CY14B101P STOREs data to the nonvolatile cells using one of the three STORE operations: AutoStore, activated on device power-down; Software STORE, activated by a <u>STORE</u> instruction; and Hardware STORE, activated by the HSB. During the STORE cycle, an erase of the previous nonvolatile data is first performed, followed by a program of the nonvolatile elements. After a STORE cycle is initiated, read/write to CY14B101P is inhibited until the cycle is completed.

The HSB signal or the RDY bit in the Status Register can be monitored by the system to detect if a STORE or Software RECALL cycle is in progress. The busy status of nvSRAM is indicated by HSB being pulled LOW or RDY bit being set to '1'. To avoid unnecessary nonvolatile STOREs, AutoStore and Hardware STORE operations are ignored unless at least one write operation has taken place since the most recent STORE or RECALL cycle. However, software initiated STORE cycles are performed regardless of whether a write operation took place.

#### **AutoStore Operation**

The AutoStore operation is a unique feature of nvSRAM, which automatically stores the SRAM data to QuantumTrap during power-down. This STORE makes use of an external capacitor (V<sub>CAP</sub>) and enables the device to safely STORE the data in the nonvolatile memory when power goes down.

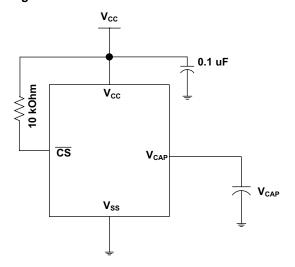
During normal operation, the device draws current from  $V_{CC}$  to charge the capacitor connected to the  $V_{CAP}$  pin. When the voltage on the  $V_{CC}$  pin drops below  $V_{SWITCH}$  during power-down, the device inhibits all memory accesses to nvSRAM and automatically performs a conditional STORE operation using the charge from the  $V_{CAP}$  capacitor. The AutoStore operation is not initiated if no write cycle was performed since the last RECALL.

**Note** If a capacitor is not connected to  $V_{CAP}$  pin, AutoStore must be disabled by issuing the AutoStore Disable instruction specified in AutoStore Disable (ASDISB) instruction on page 15. If AutoStore is enabled without a capacitor on  $V_{CAP}$  pin, the device attempts an AutoStore operation without sufficient charge to complete the Store. This corrupt the data stored in nvSRAM and Status Register. To resume normal functionality, the WRSR instruction must be issued to update the nonvolatile bits BP0, BP1 and WPEN in the Status Register.



Figure 2 shows the proper connection of the storage capacitor ( $V_{CAP}$ ) for AutoStore operation. See DC Electrical Characteristics on page 24 for the size of the  $V_{CAP}$ .

Figure 2. AutoStore Mode



#### **Software STORE Operation**

Software STORE allows the user to trigger a STORE operation through a special SPI instruction. STORE operation is initiated by executing STORE instruction irrespective of whether a write has been performed since the last NV operation.

A STORE cycle takes  $t_{STORE}$  time to complete, during <u>whi</u>ch all the memory accesses to nv<u>SRAM</u> are inhibited. The RDY bit of the Status Register or the HSB pin may be polled to find the Ready/Busy status of the nvSRAM. After the  $t_{STORE}$  cycle time is completed, the SRAM is activated again for read and write operations.

#### **Hardware STORE and HSB Pin Operation**

The HSB pin in CY14B101P is used to control and acknowledge STORE operations. If no STORE/RECALL is in progress, this pin can be used to request a Hardware STORE cycle. When the HSB pin is driven LOW, the CY14B101P conditionally initiates a STORE operation after  $t_{DELAY}$  duration. A STORE cycle starts only if a write to the SRAM was performed since the last STORE or RECALL cycle. Reads and writes to the memory are inhibited for  $t_{STORE}$  duration or as long as  $\overline{\text{HSB}}$  pin is LOW. The  $\overline{\text{HSB}}$  pin also acts as an open drain driver (internal 100 k $\Omega$  weak pull-up resistor) that is internally driven LOW to indicate a busy condition when the STORE (initiated by any means) is in progress.

**Note** After each Hardware and Software STORE operation  $\overline{\text{HSB}}$  is driven HIGH for a short time (t<sub>HHHD</sub>) with standard output high current and then remains HIGH by an internal 100 k $\Omega$  pull-up resistor

**Note** For successful last data byte STORE, a hardware store should be initiated atleast one clock cycle after the last data bit D0 is received.

Upon completion of the STORE operation, the nvSRAM memory access is inhibited for  $t_{LZHSB}$  time after HSB pin returns HIGH. The HSB pin must be left unconnected if not used.

#### **RECALL Operation**

A RECALL operation transfers the data stored in the nonvolatile QuantumTrap elements to the SRAM. In CY14B101P, a RECALL may be initiated in two ways: Hardware RECALL, initiated on power-up; and Software RECALL, initiated by a SPI RECALL instruction.

Internally, RECALL is a two step procedure. First, the SRAM data is cleared. Next, the nonvolatile information is transferred into the SRAM cells. All memory accesses are inhibited while a RECALL cycle is in progress. The RECALL operation does not alter the data in the nonvolatile elements.

#### Hardware RECALL (Power-Up)

During Power-up, when  $V_{CC}$  crosses  $V_{SWITCH}$ , an automatic RECALL sequence is initiated, which transfers the content of nonvolatile memory on to the SRAM.

A Power-up RECALL cycle takes  $t_{\text{FA}}$  time to complete and the memory access is disabled during this time. HSB pin is used to detect the Ready status of the device.

#### Software RECALL

Software RECALL allows the user to initiate a RECALL operation to restore the content of nonvolatile memory on to the SRAM. In CY14B101P, this can be done by issuing a RECALL instruction in SPI.

A Software RECALL takes  $t_{RECALL}$  time to complete during which all memory accesses to nvSRAM are inhibited. The controller must provide sufficient delay for the RECALL operation to complete before issuing any memory access instructions.

#### **Disabling and Enabling AutoStore**

If the application does not require the AutoStore feature, it can be disabled in CY14B101P by using the ASDISB instruction. If this is done, the nvSRAM does not perform a STORE operation at power-down.

AutoStore can be re-enabled by using the ASENB instruction. However, these operations are not nonvolatile and if the user needs this setting to survive the power cycle, a STORE operation must be performed following AutoStore Disable or Enable operation.

**Note** CY14B101P comes from the factory with AutoStore Enabled and with 0x00 written in all cells.

**Note** If AutoStore is disabled and  $V_{CAP}$  is not required, then the  $V_{CAP}$  pin must be left open. The  $V_{CAP}$  pin must never be connected to ground. The Power-Up RECALL operation cannot be disabled in any case.



#### **Serial Peripheral Interface**

#### **SPI Overview**

The SPI is a four-pin interface with Chip Select ( $\overline{CS}$ ), Serial Input (SI), Serial Output (SO), and Serial Clock (SCK) pins. CY14B101P provides serial access to nvSRAM through SPI interface. The SPI bus on CY14B101P can run at speeds up to 40 MHz for all instructions except RDRTC which runs at 25 MHz.

The SPI is a synchronous serial interface, which uses clock and data pins for memory access and supports multiple devices on the data bus. A device on SPI bus is activated using the CS pin.

The relationship between chip select, clock, and data is dictated by the SPI mode. CY14B101P supports SPI modes 0 and 3. In both these modes, data is clocked into the nvSRAM on the rising edge of SCK starting from the first rising edge after CS goes active.

The SPI protocol is controlled by opcodes. These opcodes specify the commands from the bus master to the slave device. After CS is activated the first byte transferred from the bus master is the opcode. Following the opcode, any addresses and data are then transferred. The CS must go inactive after an operation is complete and before a new opcode can be issued.

The commonly used terms used in SPI protocol are as follows:

#### SPI Master

The SPI master device controls the operations on a SPI bus. A SPI bus may have only one master with one or more slave devices. All the slaves share the same SPI bus lines and the master may select any of the slave devices using the  $\overline{CS}$  pin. All the operations must be initiated by the master activating a slave device by pulling the  $\overline{CS}$  pin of the slave LOW. The master also generates the SCK and all the data transmission on SI and SO lines are synchronized with this clock.

#### SPI Slave

The SPI slave device is activated by the master through the chip select line. A slave device gets the SCK as an input from the SPI master and all the communication is synchronized with this clock. SPI slave never initiates a communication on the SPI bus and acts on the instruction from the master.

CY14B101P operates as a slave device and may share the SPI bus with multiple CY14B101P devices or other SPI devices.

#### Chip Select (CS)

For selecting any slave device, the master needs to pull-down the corresponding  $\overline{CS}$  pin. Any instruction can be issued to a slave device only when the  $\overline{CS}$  pin is LOW.

The CY14B101P is selected when the  $\overline{\text{CS}}$  pin is LOW. When the device is not selected, data through the SI pin is ignored and the serial output pin (SO) remains in a high-impedance state.

**Note** A new instruction must begin with the falling edge of  $\overline{\text{CS}}$ . Therefore, only one opcode can be issued for each active chip select cycle.

#### Serial Clock (SCK)

Serial clock is generated by the SPI master  $\underline{and}$  the communication is synchronized with this clock after  $\overline{CS}$  goes LOW.

CY14B101P allows SPI modes 0 and 3 for data communication. In both these modes, the inputs are latched by the slave device on the rising edge of SCK and outputs are issued on the falling edge. Therefore, the first rising edge of SCK signifies the arrival of the first bit (MSB) of SPI instruction on the SI pin. Further, all data inputs and outputs are synchronized with SCK.

#### Data Transmission SI/SO

SPI data bus consists of two lines, SI and SO, for serial data communication. The SI is also referred to as Master out slave In (MOSI) and SO is referred to as Master in slave out (MISO). The master issues instructions to the slave through the SI pin, while the slave responds through the SO pin. Multiple slave devices may share the SI and SO lines as described earlier.

CY14B101P has two separate pins for SI and SO which can be connected with the master as shown in Figure 3 on page 7.

#### Most Significant Bit (MSB)

The SPI protocol requires that the first bit to be transmitted is the Most significant bit (MSB). This is valid for both address and data transmission.

CY14B101P requires a 3-byte address for any read or write operation. However, since the actual address is only 17 bits, it implies that the first seven bits, which are fed in, are ignored by the device. Although these seven bits are 'don't care', Cypress recommends that these bits are treated as 0s to enable seamless transition to higher memory densities.

#### Serial Opcode

After the slave device is selected with  $\overline{CS}$  going LOW, the first byte received is treated as the opcode for the intended operation.

CY14B101P uses the standard opcodes for memory accesses. In addition to the memory accesses, CY14B101P provides additional opcodes for the nvSRAM specific functions: STORE, RECALL, AutoStore Enable, and AutoStore Disable. Refer to Table 1 on page 8 for details on opcodes.

#### Invalid Opcode

If an invalid opcode is received, the opcode is ignored and the device ignores <u>any</u> additional serial data on the SI pin till the next falling edge of CS and the SO pin remains tristated.

#### Status Register

CY14B101P has an 8-bit Status Register. The bits in the Status Register are used to configure the SPI bus. These bits are described in the Table 3 on page 9.



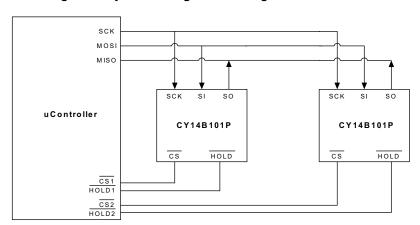


Figure 3. System Configuration Using SPI nvSRAM

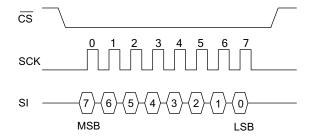
#### **SPI Modes**

CY14B101P device may be driven by a microcontroller with its SPI peripheral running in either of those two modes:

- SPI Mode 0 (CPOL=0, CPHA=0)
- SPI Mode 3 (CPOL=1, CPHA=1)

For both these modes, the input data is latched in on the rising edge of SCK starting from the first rising edge after CS goes active. If the clock starts from a HIGH state (in mode 3), the first rising edge after the clock toggles is considered. The output data is available on the falling edge of SCK.

Figure 4. SPI Mode 0

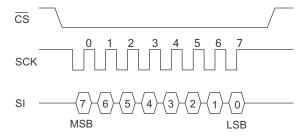


The two SPI modes are shown in Figure 4 and Figure 5. The status of clock when the bus master is in standby mode and not transferring data is:

- SCK remains at 0 for Mode 0
- SCK remains at 1 for Mode 3

CPOL and CPHA bits must be set in the SPI controller for the either Mode 0 or Mode 3. CY14B101P detects the SPI mode from the status of SCK pin when the device is selected by bringing the CS pin LOW. If SCK pin is LOW when the device is selected, SPI Mode 0 is assumed and if SCK pin is HIGH, CY14B101P works in SPI Mode 3.

Figure 5. SPI Mode 3





#### **SPI Operating Features**

#### Power-Up

Power-up is defined as the condition when the power supply is turned on and  $V_{CC}$  crosses  $V_{SWITCH}$  voltage. During this time, the CS must be enabled to follow the  $V_{CC}$  voltage. Therefore, CS must be connected to  $V_{CC}$  through a suitable pull-up resistor. As a built in safety feature, CS is both edge sensitive and level sensitive. After power-up, the device is not selected until a falling edge is detected on CS. This ensures that CS is HIGH, before going LOW to start the first operation.

As described earlier, nvSRAM performs a Power-Up RECALL operation after power-up and therefore, all memory accesses are disabled for  $t_{\text{FA}}$  duration after power-up. The HSB pin can be probed to check the ready/busy status of nvSRAM after power-up.

#### **Power-On Reset**

A power-on reset (POR) circuit is included to prevent inadvertent writes. At power-up, the device does not respond to any instruction until the  $V_{CC}$  reaches the POR threshold voltage ( $V_{\rm SWITCH}$ ). After  $V_{\rm CC}$  transitions the POR threshold, the device is internally reset and performs an Power-Up RECALL operation. During Power-Up RECALL all device accesses are inhibited. The device is in the following state after POR:

- Deselected (after power-up, a falling edge is required on CS before any instructions are started).
- Standby power mode
- Not in the HOLD Condition
- Status Register state:
  - □ Write Enable (WEN) bit is reset to 0.
  - □ WPEN, BP1, BP0 unchanged from previous STORE operation
  - □ Don't care bits 4-6 are reset to 0.

The WPEN, BP1, and BP0 bits of the Status Register are nonvolatile bits and remain unchanged from the previous STORE operation.

Before selecting and issuing instructions to the memory, a valid and stable  $V_{CC}$  voltage must be applied. This voltage must remain valid until the end of the instruction transmission.

#### **Power-Down**

At power-down (continuous decay of  $V_{CC}$ ), when  $V_{CC}$  drops from the normal operating voltage and below the  $V_{SWITCH}$  threshold voltage, the device stops responding to any instruction sent to it. If a write cycle is in progress and the last data bit D0 has been received when the power goes down, it is allowed  $t_{DELAY}$  time to complete the write. After this, all memory accesses are inhibited and a conditional AutoStore operation is performed (AutoStore is not performed if no writes have happened since last RECALL cycle). This feature prevents inadvertent writes to nvSRAM from happening during power-down.

However, to avoid the possibility of inadvertent writes during power-down, ensure that the <u>de</u>vice is deselected and is in standby power mode, and the CS follows the voltage applied on  $V_{CC}$ .

#### **Active Power and Standby Power Modes**

When  $\overline{\text{CS}}$  is LOW, the device is selected and is in the active power mode. The device consumes I<sub>CC</sub> current, <u>as</u> specified in DC Electrical Characteristics on page 24. When CS is HIGH, the device is deselected and the device goes into the standby power mode if a STORE or RECALL cycle is not in progress. If a STORE/RECALL cycle is in progress, the device goes into the standby power mode after the STORE/RECALL cycle is completed. In the standby power mode the current drawn by the device drops to I<sub>SB</sub>.

#### **SPI Functional Description**

The CY14B101P uses an 8-bit instruction register. Instructions and their operation codes are listed in Table 1. All instructions, addresses, and data are transferred with the MSB first and start with a HIGH to LOW CS transition. There are, in all, 12 SPI instructions that provide access to most of the functions in nvSRAM. Further, the WP, HOLD and HSB pins provide additional functionality driven through hardware.

**Table 1. Instruction Set** 

Instruction Category	Instruction Name	Opcode	Operation
	WREN	0000 0110	Set Write Enable latch
Status Register Instructions	WRDI	0000 0100	Reset Write Enable latch
	RDSR	0000 0101	Read Status Register
	WRSR	0000 0001	Write Status Register
SRAM Read/Write	READ	0000 0011	Read data from memory array
Instructions	WRITE	0000 0010	Write data to memory array
RTC Read/Write	WRTC	0001 0010	Write RTC registers
Instructions	RDRTC	0001 0011	Read RTC Registers
	STORE	0011 1100	Software STORE
Special NV Instructions	RECALL	0110 0000	Software RECALL
II ISTI UCIIONS	ASENB	0101 1001	AutoStore Enable
	ASDISB	0001 1001	AutoStore Disable
Reserved	- Reserved -	0001 1110	

The SPI instructions in CY14B101P are divided based on their functionality in the following types:

- ☐ Status Register Access: RDSR and WRSR instructions
- □ Write protection functions: WREN and WRDI instructions along with WP pin and WEN, BP0 and BP1 bits
- □ SRAM memory access: READ and WRITE instructions
- □ RTC access: RDRTC and WRTC instructions
- nvSRAM special instructions: STORE, RECALL, ASENB, and ASDISB



### Status Register

The Status Register bits are listed in Table 2. The Status Register consists of a Ready bit (RDY) and data protection bits WEN, BP0, BP1, and WPEN. The RDY bit can be polled to check the Ready/Busy status while a nvSRAM STORE or Software RECALL cycle is in progress. The Status Register can

be modified by WRSR instruction and read by RDSR instruction. However, only the WPEN, BP1 and BP0 bits of the Status Register can be modified by using the WRSR instruction. The WRSR instruction has no effect on WEN and  $\overline{\text{RDY}}$  bits. The default value shipped from the factory for BP1, BP0, bits 4-6 and WPEN bits is '0'.

Table 2. Status Register Format

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
WPEN (0)	X (0)	X (0)	X (0)	BP1 (0)	BP0 (0)	WEN(0)	RDY

Table 3. Status Register Bit Definition

Bit	Definition	Description
Bit 0 (RDY)	Ready	Read only bit indicates the ready status of device to perform a memory access. This bit is set to '1' by the device while a STORE or Software RECALL cycle is in progress.
Bit 1 (WEN)	Write Enable	WEN indicates if the device is write-enabled. This bit defaults to '0' (disabled) on power-up.  WEN = '1'> Write Enabled  WEN = '0'> Write Disabled
Bit 2 (BP0)	Block protect bit '0'	Used for block protection. For details see Table 4 on page 11.
Bit 3 (BP1)	Block protect bit '1'	Used for block protection. For details see Table 4 on page 11.
Bits 4-6	Don't care	Bits are writable and volatile. On power-up, bits are written with '0'.
Bit 7(WPEN)	Write protect enable bit	Used for enabling the function of Write Protect Pin (WP). For details see Table 5 on page 11.

#### Read Status Register (RDSR) Instruction

The Read Status Register (RDSR) instruction provides access to the Status Register. This instruction is used to probe the Write <a href="Enable">Enable</a> Status of the device or the Ready status of the device. RDY bit is set by the device to 1 whenever a STORE or Software RECALL cycle is in progress. The block protection and WPEN bits indicate the extent of protection employed.

This instruction is issued after the falling edge of  $\overline{\text{CS}}$  using the opcode for RDSR.

#### Write Status Register (WRSR) Instruction

The WRSR instruction enables the user to write to the Status Register. However, this instruction cannot be used to modify bit 0 and bit 1 (RDY and WEN). The BP0 and BP1 bits can be used

to select one of four levels of block protection. Further, WPEN bit must be set to '1' to enable the use of Write Protect (WP) pin.

WRSR instruction is a write instruction and needs writes to be enabled (WEN bit set to '1') using the WREN instruction before it is issued. The instruction is issued after the falling edge of CS using the opcode for WRSR followed by eight bits of data to be stored in the Status Register. Since, only bits 2, 3, and 7 can be modified by WRSR instruction; therefore, it is recommended to leave the bits 4–6 as '0' while writing to the Status Register.

**Note** In CY14B101P, the values written to Status Register are saved to nonvolatile memory only after a STORE operation. If AutoStore is disabled, any modifications to the Status Register must be secured by performing a Software STORE operation.



CS

SCK

0 1 2 3 4 5 6 7 0 1 2 3 4 5 6 7

SI

0 0 0 0 0 0 1 0 1

MSB

LSB

HI-Z

Figure 6. Read Status Register (RDSR) Instruction Timing

Figure 7. Write Status Register (WRSR) Instruction Timing

MSB

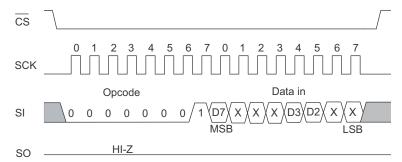
(D7)(D6)(D5)

D4\\D3\\ D2\

Data

D0

LSB



#### Write Protection and Block Protection

SO

CY14B101P provides features for both software and hardware write protection using WRDI instruction and WP. Additionally, this device also provides block protection mechanism through BP0 and BP1 pins of the Status Register.

The Write Enable and Disable status of the device is indicated by WEN bit of the Status Register. The write instructions (WRSR, WRITE, and WRTC) and nvSRAM special instruction (STORE, RECALL, ASENB, ASDISB) need the write to be enabled (WEN bit = 1) before they can be issued.

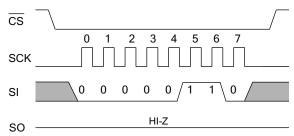
#### Write Enable (WREN) Instruction

On power-up, the device is always in the write disable state. The following WRITE, WRSR, WRTC, or nvSRAM special instruction must therefore be preceded by a Write Enable instruction. If the device is not write enabled (WEN = '0'), it ignores the write instructions and returns to the standby state when CS is brought HIGH. A new CS falling edge is required to re-initiate serial communication. The instruction is issued following the falling

edge of  $\overline{\text{CS}}$ . When this instruction is used, the WEN bit of Status Register is set to '1'. WEN bit defaults to '0' on power-up.

**Note** After completion of a write instruction (WRSR, WRITE, or WRTC) or nvSRAM special instruction (STORE, RECALL, ASENB, ASDISB) instruction, WEN bit is cleared to '0'. This is done to provide protection from any inadvertent writes. Therefore, WREN instruction must be used before a new write instruction is issued.

Figure 8. WREN Instruction

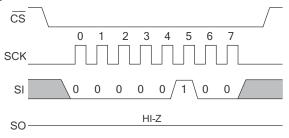




#### Write Disable (WRDI) Instruction

Write Disable instruction disables the write by clearing the WEN bit to '0' in order to protect the device against inadve<u>rte</u>nt writes. This instruction is issued following the falling edge of CS followed by opcode for <u>WRDI</u> instruction. The WEN bit is cleared on the rising edge of CS following a WRDI instruction.

Figure 9. WRDI Instruction



#### **Block Protection**

Block protection is provided using the BP0 and BP1 pins of the Status Register. These bits can be set using WRSR instruction and probed using the RDSR instruction. The nvSRAM is divided into four array segments. One-quarter, one-half, or all of the memory segments can be protected. Any data within the protected segment is read only. Table 4 shows the function of block protect bits.

**Table 4. Block Write Protect Bits** 

Level	Status Re	gister Bits	Array Addresses Protected			
Level	BP1	BP0	Allay Addresses Protected			
0	0	0	None			
1 (1/4)	0	1	0x18000-0x1FFFF			
2 (1/2)	1	0	0x10000-0x1FFFF			
3 (All)	1	1	0x00000-0x1FFFF			

#### Hardware Write Protection (WP Pin)

The write <u>protect</u> pin  $(\overline{WP})$  is used to provide hardware write protection. WP pin allows all <u>normal</u> read and write operations when held HIGH. When the  $\overline{WP}$  pin is brought LOW and WPEN bit is '1', all write operations to the Status Register are inhibited. The hardware write protection function is blocked when the WPEN bit is '0'. This allows the user to install the CY14B101P in a system with the  $\overline{WP}$  pin tied to ground, and still write to the Status Register.

WP pin can be used along with WPEN and block protect bits (BP1 and BP0) of the Status Register to inhibit writes to memory. When WP pin is LOW and WPEN is set to '1', any modifications to Status Register are disabled. Therefore, the memory is protected by setting the BP0 and BP1 bits and the WP pin inhibits any modification of the Status Register bits, providing hardware write protection.

**Note** WP going LOW when  $\overline{CS}$  is still LOW has no effect on any of the ongoing write operations to the Status Register.

Table 5 summarizes all the protection features provided in the CY14B101P.

**Table 5. Write Protection Operation** 

WPEN	WP	WEN	WEN Protected Unprotected Blocks		Status Register
Х	Х	0	Protected	Protected	Protected
0	Х	1	Protected	Writable	Writable
1	LOW	1	Protected	Writable	Protected
1	HIGH	1	Protected	Writable	Writable

#### **Memory Access**

All memory accesses are done using the READ and WRITE instructions. These instructions cannot be used while a STORE or RECALL cycle is in progress. A STORE cycle in progress is indicated by the RDY bit of the Status Register and the HSB pin.

#### Read Sequence (READ) instruction

The read operations on CY14B101P are performed by giving the instruction on the SI pin and reading the output on SO pin. The following sequence needs to be followed for a read operation: After the CS line is pulled LOW to select a device, the read opcode is transmitted through the SI line followed by three bytes of address. The most significant address byte contains A16 in bit 0 and other bits as don't cares. Address bits A15 to A0 are sent in the following two address bytes. After the last address bit is transmitted on the SI pin, the data (D7 - D0) at the specific address is shifted out on the SO line on the falling edge of SCK starting with D7. Any other data on SI line after the last address bit is ignored.

CY14B101P allows reads to be performed in bursts through SPI which can be used to read consecutive addresses without issuing a new READ instruction. If only one byte is to be read, the CS line must be driven HIGH after one byte of data comes out. However, the read sequence may be continued by holding the CS line LOW and the address is automatically incremented and data continues to shift out on SO pin. When the last data memory address (0x1FFFF) is reached, the address rolls over to 0x0000 and the device continues to read.

#### Write Sequence (WRITE) instruction

The write operations on CY14B101P are performed through the SI pin. To perform a write operation CY14B101P, if the device is write disabled, then the device must first be write enabled through the WREN instruction. When the writes are enabled (WEN = '1'), WRITE instruction is issued after the falling edge of CS. A WRITE instruction constitutes transmitting the WRITE opcode on SI line followed by 3-bytes of address and the data (D7-D0) which is to be written. The Most Significant address byte contains A16 in bit 0 with other bits being don't cares. Address bits A15 to A0 are sent in the following two address bytes.

CY14B101P allows writes to be performed in bursts through SPI which can be used to write consecutive addresses without issuing a new WRITE instruction. If only one byte is to be written, the CS line must be driven HIGH after the D0 (LSB of data) is transmitted. However, if more bytes are to be written, CS line must be held LOW and address incremented automatically. The following bytes on the SI line are treated as data bytes and written in the successive addresses. When the last data memory



address (0x1FFFF) is reached, the address rolls over to 0x0000 and the device continues to write.

The WEN bit is reset to '0' on completion of a WRITE sequence.

Note When a burst write reaches a protected block address, it continues the address increment into the protected space but

does not write any data to the protected memory. If the address roll over takes the burst write to unprotected space, it resumes writes. The same operation is true if a burst write is initiated within a write protected block.

Figure 10. Read Instruction Timing

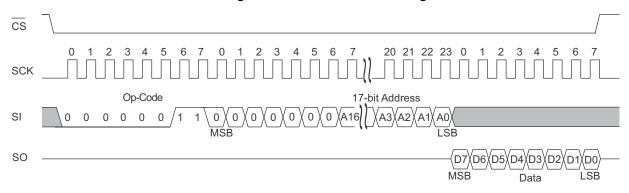


Figure 11. Burst Mode Read Instruction Timing

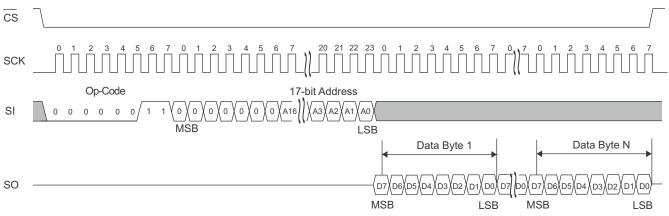
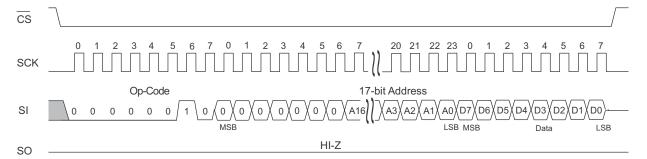


Figure 12. Write Instruction Timing





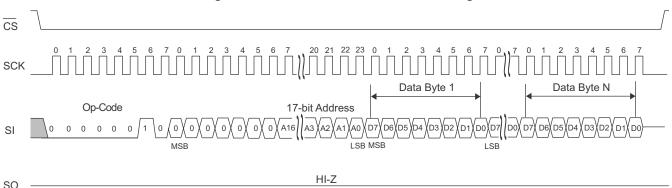


Figure 13. Burst Mode Write Instruction Timing

#### **RTC Access**

CY14B101P uses 16 registers for RTC. These registers can be read out or written to by accessing all 16 registers in burst mode or accessing each register, one at a time. The RDRTC and WRTC instructions are used to access the RTC.

All the RTC registers can be read in burst mode by issuing the RDRTC instruction and reading all 16 bytes without bringing the CS pin HIGH. The 'R' bit must be set while reading the RTC timekeeping registers to ensure that transitional values of time are not read.

Writes to the RTC register are performed using the WRTC instruction. Writing RTC timekeeping registers and control registers, except for the flags register needs the 'W' bit of the flags register to be set to '1'. The internal counters are updated with the new date and time setting when the 'W' bit is cleared to '0'. All the RTC registers can also be written in burst mode using the WRTC instruction.

#### READ RTC (RDRTC) Instruction

Read RTC (RDRTC) instruction allows the user to read the contents of RTC registers. Reading the RTC registers through

the SO pin requires the following sequence: After the  $\overline{\text{CS}}$  line is pulled LOW to select a device, the RDRTC opcode is transmitted through the SI line followed by eight address bits for selecting the register. Any data on the SI line after the address bits is ignored. The data (D7-D0) at the specified address is then shifted out onto the SO line. RDRTC also allows burst mode read operation. When reading multiple bytes from RTC registers, the address rolls over to 0x00 after the last RTC register address (0x0F) is reached.

The 'R' bit in RTC flags register must be set to '1' before reading RTC time keeping registers to avoid reading transitional data. Modifying the RTC flags registers requires a Write RTC cycle. The 'R' bit must be cleared to '0' after completion of the read operation.

The easiest way to read RTC registers is to perform RDRTC in burst mode. The read may start from the first RTC register (0x00) and the CS must be held LOW to allow the data from all 16 RTC registers to be transmitted through the SO pin.

**Note** Read RTC (RDRTC) instruction operates at a maximum clock frequency of 25 MHz. The opcode cycles, address cycles and data out cycles need to run at 25 MHz for the instruction to work properly.

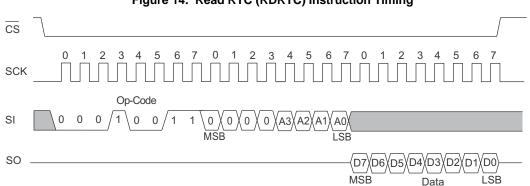


Figure 14. Read RTC (RDRTC) Instruction Timing

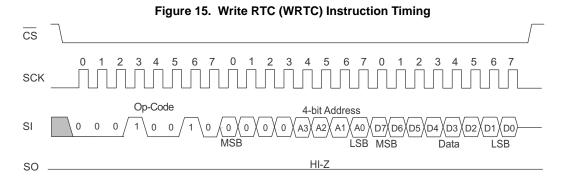


#### WRITE RTC (WRTC) Instruction

WRITE RTC (WRTC) instruction allows the user to modify the contents of RTC registers. The WRTC instruction requires the WEN bit to be set to '1' before it can be issued. If WEN bit is '0', a WREN instruction needs to be issued before using WRTC. Writing RTC registers requires the following sequence: After the CS line is pulled LOW to select a device, WRTC opcode is transmitted through the SI line followed by eight address bits identifying the register which is to be written to and one or more

bytes of data. WRTC allows burst mode write operation. When writing more than one registers in burst mode, the address rolls over to 0x00 after the last RTC address (0x0F) is reached.

Note that writing to RTC timekeeping and control registers require the 'W' bit to be set to '1'. The values in these RTC registers take effect only after the W bit is cleared to '0'. Write Enable bit (WEN) is automatically cleared to '0' after completion of the WRTC instruction.



### **nvSRAM Special Instructions**

CY14B101P provides four special instructions that allow access to the nvSRAM specific functions: STORE, RECALL, ASDISB, and ASENB. Table 6 lists these instructions.

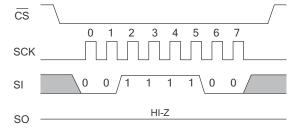
Table 6. nvSRAM Special Instructions

Function Name	Opcode	Operation
STORE	0011 1100	Software STORE
RECALL	0110 0000	Software RECALL
ASENB	0101 1001	AutoStore Enable
ASDISB	0001 1001	AutoStore Disable

#### Software STORE (STORE) instruction

When a STORE instruction is executed, CY14B101P performs a Software STORE operation. The STORE operation is performed irrespective of whether a write has taken place since the last STORE or RECALL operation.

Figure 16. Software STORE Operation



To issue this instruction, the device must be write enabled (WEN bit = '1'). The instruction is performed by transmitting the STORE opcode on the SI pin following the falling edge of  $\overline{\text{CS}}$ .

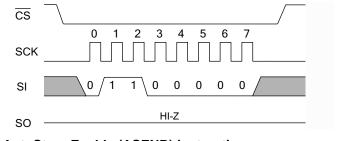
The WEN bit is cleared on the positive edge of  $\overline{CS}$  following the STORE instruction.

#### Software RECALL (RECALL) instruction

When a RECALL instruction is executed, CY14B101P performs a Software RECALL operation. To issue this instruction, the device must be write enabled (WEN = '1').

The instruction is performed by transmitting the RECALL opcode on the SI pin following the falling edge of  $\overline{\text{CS}}$ . The WEN bit is cleared on the positive edge of  $\overline{\text{CS}}$  following the RECALL instruction.

Figure 17. Software RECALL Operation



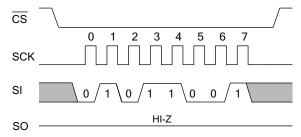
#### AutoStore Enable (ASENB) instruction

The AutoStore Enable instruction enables the AutoStore on CY14B101P. This setting is not nonvolatile and needs to be followed by a STORE sequence if this is desired to survive the power cycle.

To issue this instruction, the device must be write enabled (WEN = '1'). The instruction is performed by transmitting the ASENB opcode on the SI pin following the falling edge of  $\overline{CS}$ . The WEN bit is cleared on the positive edge of  $\overline{CS}$  following the ASENB instruction.



Figure 18. AutoStore Enable Operation

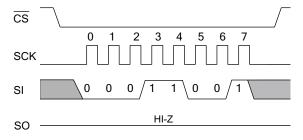


#### AutoStore Disable (ASDISB) instruction

AutoStore is enabled by default in CY14B101P. The AutoStore Disable instruction disables the AutoStore on CY14B101P. This setting is not nonvolatile and needs to be followed by a STORE sequence if this is desired to survive the power cycle.

To issue this instruction, the device must be write enabled (WEN = '1'). The instruction is performed by transmitting the ASDISB opcode on the SI pin following the falling edge of  $\overline{CS}$ . The WEN bit is cleared on the positive edge of  $\overline{CS}$  following the ASDISB instruction.

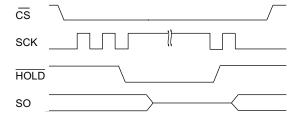
Figure 19. AutoStore Disable Operation



#### **HOLD Pin Operation**

The HOLD pin is used to pause the serial communication. When the device is selected and a serial sequence is underway, HOLD is used to pause the serial communication with the master device without resetting the ongoing serial sequence. To pause, the HOLD pin must be brought LOW when the SCK pin is LOW. CS pin must remain LOW along with HOLD pin to pause serial communication. While the device serial communication is paused, inputs to the SI pin are ignored and the SO pin is in the high impedance state. To resume serial communication, the HOLD pin must be brought HIGH when the SCK pin is LOW (SCK may toggle during HOLD).

Figure 20. HOLD Operation





#### **Real Time Clock Operation**

#### nvTIME Operation

The CY14B101P offers internal registers that contain clock, alarm, watchdog, interrupt, and control functions. The RTC registers occupy a separate address space from nvSRAM and are accessible through the Read RTC register and Write RTC register sequence on register addresses 0x00 to 0x0F. Internal double buffering of the time keeping registers prevents accessing transitional internal clock data during a read or write operation. Double buffering also circumvents disrupting normal timing counts or the clock accuracy of the internal clock when accessing clock data. Clock and alarm registers store data in BCD format.

#### **Clock Operations**

The clock registers maintain time up to 9,999 years in one-second increments. The time can be set to any calendar time and the clock automatically keeps track of days of the week and month, leap years, and century transitions. There are eight registers dedicated to the clock functions, which are used to set time with a write cycle and to read time with a read cycle. These registers contain the time of day in BCD format. Bits defined as '0' are currently not used and are reserved for future use by Cypress.

#### Reading the Clock

The double buffered RTC register structure reduces the chance of reading incorrect data from the clock. Internal updates to the CY14B101P time keeping registers are stopped when the read bit 'R' (in the flags register at 0x00) is set to '1' before reading clock data to prevent reading of data in transition. Stopping the register updates does not affect clock accuracy.

When a read sequence of RTC device is initiated, the update of the user timekeeping registers stops and does not restart until a '0' is written to the read bit 'R' (in the flags register at 0x00). After the end of read sequence, all the RTC registers are simultaneously updated within 20 ms.

#### Setting the Clock

A write access to the RTC device stops updates to the time keeping registers and enables the time to be set when the write bit 'W' (in the flags register at 0x00) is set to '1'. The correct day, date, and time is then written into the registers and must be in 24 hour BCD format. The time written is referred to as the "Base Time". This value is stored in nonvolatile registers and used in the calculation of the current time. When the write bit 'W' is cleared by writing '0' to it, the values of timekeeping registers are transferred to the actual clock counters after which the clock resumes normal operation.

If the time written to the timekeeping registers is not in the correct BCD format, each invalid nibble of the RTC registers continue counting to 0xF before rolling over to 0x0 after which RTC resumes normal operation.

**Note** After 'W' bit is set to '0', values written into the timekeeping, alarm, calibration, and interrupt registers are transferred to the RTC time keeping counters in  $t_{RTCp}$  time. These counter values must be saved to nonvolatile memory either by initiating a Software/Hardware STORE or AutoStore operation. While working in AutoStore disabled mode, perform a STORE

operation after  $t_{\text{RTCp}}$  time while writing into the RTC registers for the modifications to be correctly recorded.

#### **Backup Power**

The RTC in the CY14B101P is intended for permanently powered operation. The  $V_{RTCcap}$  or  $V_{RTCbat}$  pin is connected depending on whether a capacitor or battery is chosen for the application. When the primary power,  $V_{CC}$ , fails and drops below  $V_{SWITCH}$  the device switches to the backup power supply.

The clock oscillator uses very little current, which maximizes the backup time available from the backup source. Regardless of the clock operation with the primary source removed, the data stored in the nvSRAM is secure, having been stored in the nonvolatile elements when power was lost.

During backup operation, the CY14B101P consumes a  $0.35~\mu A$  (Typ) at room temperature. The user must choose capacitor or battery values according to the application.

Backup time values based on maximum current specifications are shown in the following Table 7. Nominal backup times are approximately two times longer.

Table 7. RTC Backup Time

Capacitor Value	Backup Time
0.1 F	72 hours
0.47 F	14 days
1.0 F	30 days

Using a capacitor has the obvious advantage of recharging the backup source each time the system is powered up. If a battery is used, a 3 V lithium is recommended and the CY14B101P sources current only from the battery when the primary power is removed. However, the battery is not recharged at any time by the CY14B101P. The battery capacity must be chosen for total anticipated cumulative down time required over the life of the system.

#### Stopping and Starting the Oscillator

The OSCEN bit in the calibration register at 0x08 controls the enable and disable of the oscillator. This bit is nonvolatile and is shipped to customers in the "enabled" (set to '0') state. To preserve the battery life when the system is in storage, OSCEN must be set to '1'. This turns off the oscillator circuit, extending the battery life. If the OSCEN bit goes from disabled to enabled, it takes approximately one second (two seconds maximum) for the oscillator to start.

While system power is off, if the voltage on the backup supply ( $V_{RTCcap}$  or  $V_{RTCbat}$ ) falls below their respective minimum level, the oscillator may fail. The CY14B101P has the ability to detect oscillator failure when system power is restored. This is recorded in the Oscillator Fail Flag (OSCF) of the flags register at the address 0x00. When the device is powered on ( $V_{CC}$  goes above  $V_{SWITCH}$ ) the OSCEN bit is checked for the 'enabled' status. If the OSCEN bit is enabled and the oscillator is not active within the first 5 ms, the OSCF bit is set to '1'. The system must check for this condition and then write '0' to clear the flag.

Note that in addition to setting the OSCF flag bit, the time registers are reset to the 'Base Time', which is the value last written to the timekeeping registers. The control or calibration



registers and the OSCEN bit are not affected by the 'oscillator failed' condition.

The value of OSCF must be reset to '0' when the time registers are written for the first time. This initializes the state of this bit which may have become set when the system was first powered on.

To reset OSCF, set the write bit 'W' (in the flags register at 0x00) to a '1' to enable writes to the flags register. Write a '0' to the OSCF bit and then reset the write bit to '0' to disable writes.

#### Calibrating the Clock

The RTC is driven by a quartz controlled crystal with a nominal frequency of 32.768 kHz. Clock accuracy depends on the quality of the crystal and calibration. The crystals available in market typically have an error of  $\pm 20$  ppm to  $\pm 35$  ppm. However, CY14B101P employs a calibration circuit that improves the accuracy to  $\pm 1/-2$  ppm at 25 °C. This implies an error of  $\pm 2.5$  seconds to  $\pm 3$  seconds per month.

The calibration circuit adds or subtracts counts from the oscillator divider circuit to achieve this accuracy. The number of pulses that are suppressed (subtracted, negative calibration) or split (added, positive calibration) depends upon the value loaded into the five calibration bits found in calibration register at 0x08. The calibration bits occupy the five lower order bits in the calibration register. These bits are set to represent any value between '0' and 31 in binary form. Bit D5 is a sign bit, where a '1' indicates positive calibration and a '0' indicates negative calibration. Adding counts speeds the clock up and subtracting counts slows the clock down. If a binary '1' is loaded into the register, it corresponds to an adjustment of 4.068 or –2.034 ppm offset in oscillator error, depending on the sign.

Calibration occurs within a 64-minute cycle. The first 62 minutes in the cycle may, once per minute, have one second shortened by 128 or lengthened by 256 oscillator cycles. If a binary '1' is loaded into the register, only the first two minutes of the 64-minute cycle are modified. If a binary 6 is loaded, the first 12 are affected, and so on. Therefore, each calibration step has the effect of adding 512 or subtracting 256 oscillator cycles for every 125,829,120 actual oscillator cycles, that is, 4.068 or –2.034 ppm of adjustment per calibration step in the calibration register.

To determine the required calibration, the CAL bit in the flags register (0x00) must be set to '1'. This causes the INT pin to toggle at a nominal frequency of 512 Hz. Any deviation measured from the 512 Hz indicates the degree and direction of the required correction. For example, a reading of 512.01024 Hz indicates a +20 ppm error. Hence, a decimal value of -10 (001010b) must be loaded into the calibration register to offset this error.

**Note** Setting or changing the calibration register does not affect the test output frequency.

To set or clear CAL, set the write bit 'W' (in the flags register at 0x00) to '1' to enable writes to the flags register. Write a value to CAL, and then reset the write bit to '0' to disable writes.

#### Alarm

The alarm function compares user programmed values of alarm time and date (stored in the registers 0x01-5) with the

corresponding time of day and date values. When a match occurs, the alarm internal flag (AF) is set and an interrupt is generated on INT pin if Alarm Interrupt Enable (AIE) bit is set.

There are four alarm match fields: date, hours, minutes, and seconds. Each of these fields has a match bit that is used to determine if the field is used in the alarm match logic. Setting the match bit to '0' indicates that the corresponding field is used in the match process. Depending on the match bits, the alarm occurs as specifically as once a month or as frequently as once every minute. Selecting none of the match bits (all 1s) indicates that no match is required and therefore, alarm is disabled. Selecting all match bits (all 0s) causes an exact time and date match

There are two ways to detect an alarm event: by reading the AF flag or monitoring the INT pin. The AF flag in the flags register at 0x00 indicates that a date or time match has occurred. The AF bit is set to '1' when a match occurs. Reading the flags register clears the alarm flag bit (and all others). A hardware interrupt pin may also be used to detect an alarm event.

To set, clear or enable an alarm, set the 'W' bit (in the flags register - 0x00) to '1' to enable writes to alarm registers. After writing the alarm value, clear the 'W' bit back to '0' for the changes to take effect.

**Note** CY14B101P requires the alarm match bit for seconds (bit 'D7' in Alarm-Seconds register 0x02) to be set to '0' for proper operation of Alarm Flag and Interrupt.

#### **Watchdog Timer**

The watchdog timer is a free running down counter that uses the 32 Hz clock (31.25 ms) derived from the crystal oscillator. The oscillator must be running for the watchdog to function. It begins counting down from the value loaded in the Watchdog Timer register.

The timer consists of a loadable register and a free running counter. On power-up, the watchdog time out value in register 0x07 is loaded into the counter load register. Counting begins on power-up and restarts from the loadable value any time the Watchdog strobe (WDS) bit is set to '1'. The counter is compared to the terminal value of '0'. If the counter reaches this value, it causes an internal flag and an optional interrupt output. You can prevent the time out interrupt by setting WDS bit to '1' prior to the counter reaching '0'. This causes the counter to reload with the watchdog time out value and to be restarted. As long as the user sets the WDS bit prior to the counter reaching the terminal value, the interrupt and WDT flag never occur.

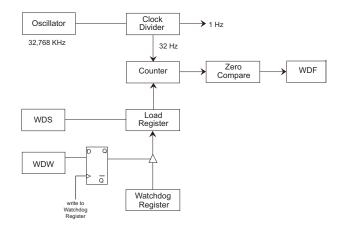
New time out values are written by setting the watchdog write bit to '0'. When the WDW is '0', new writes to the watchdog time out value bits D5-D0 are enabled to modify the time out value. When WDW is '1', writes to bits D5-D0 are ignored. The WDW function enables a user to set the WDS bit without concern that the watchdog timer value is modified. A logical diagram of the watchdog timer is shown in Figure 21 on page 18. Note that setting the watchdog time out value to '0' disables the watchdog function.

The output of the watchdog timer is the flag bit WDF that is set if the watchdog is allowed to time out. If the watchdog interrupt enable (WIE) bit in the interrupt register is set, a hardware interrupt on INT pin is also generated on watchdog timeout. The



flag and the hardware interrupt are both cleared when user reads the flags register.

Figure 21. Watchdog Timer Block Diagram



#### **Power Monitor**

The CY14B101P provides a power management scheme with power fail interrupt capability. It also controls the internal switch to backup power for the clock and protects the memory from low  $V_{CC}$  access. The power monitor is based on an internal bandgap reference circuit that compares the  $V_{CC}$  voltage to  $V_{SWITCH}$  threshold.

As described in the section AutoStore Operation on page 4, when  $V_{SWITCH}$  is reached as  $V_{CC}$  decays from power loss, a data STORE operation is initiated from SRAM to the nonvolatile elements, securing the last SRAM data state. Power is also switched from  $V_{CC}$  to the backup supply (battery or capacitor) to operate the RTC oscillator.

When operating from the backup source, read and write operations to nvSRAM are inhibited and the RTC functions are not available to the user. The RTC clock continues to operate in the background. The updated RTC time keeping registers data are available to the user after  $V_{CC}$  is restored to the device (see AutoStore or Power-Up RECALL on page 28).

#### Interrupts

The CY14B101P has a flags register, interrupt register, and Interrupt logic that can signal interrupt to the microcontroller. There are three potential sources for interrupt: watchdog timer, power monitor, and alarm timer. Each of these can be individually enabled to drive the INT pin by appropriate setting in the interrupt register (0x06). In addition, each has an associated flag bit in the flags register (0x00) that the host processor uses to determine the cause of the interrupt. The INT pin driver has two bits that specify its behavior when an interrupt occurs.

An interrupt is raised only if both a flag is raised by one of the three sources and the respective interrupt enable bit in interrupts register is enabled (set to '1'). After an interrupt source is active, two programmable bits, H/L and P/L, determine the behavior of the output pin driver on INT pin. These two bits are located in the

interrupt register and can be used to drive level or pulse mode output from the INT pin. In pulse mode, the pulse width is internally fixed at approximately 200 ms. This mode is intended to reset a host microcontroller. In the level mode, the pin goes to its active polarity until the flags register is read by the user. This mode is used as an interrupt to a host microcontroller. The control bits are summarized in the following section.

Interrupts are only generated while working on normal power and are not triggered when system is running in backup power mode.

**Note** CY14B101P generates valid interrupts only after the Power-Up RECALL sequence is completed. All events on INT pin must be ignored for  $t_{\text{FA}}$  duration after power-up.

#### **Interrupt Register**

**Watchdog Interrupt Enable (WIE).** When set to '1', the watchdog timer drives the INT pin and an internal flag when a watchdog time out occurs. When WIE is set to '0', the watchdog timer only affects the WDF flag in flags register.

**Alarm Interrupt Enable (AIE).** When set to '1', the alarm match drives the INT pin and an internal flag. When AIE is set to '0', the alarm match only affects the AF flag in flags register.

**Power Fail Interrupt Enable (PFE).** When set to '1', the power fail monitor drives the pin and an internal flag. When PFE is set to '0', the power fail monitor only affects the PF flag in flags register.

**High/Low (H/L).** When set to a '1', the INT pin is active HIGH and the driver mode is push pull. The INT pin drives HIGH only when  $V_{CC}$  is greater than  $V_{SWITCH}$ . When set to a '0', the INT pin is active LOW and the drive mode is open drain. The INT pin must be pulled up to  $V_{CC}$  by a 10 k resistor while using the interrupt in active LOW mode.

**Pulse/Level (P/L).** When set to a '1' and an interrupt occurs, the INT pin is driven for approximately 200 ms. When P/L is set to a '0', the INT pin is driven HIGH or LOW (determined by H/L) until the flags register is read.

When an enabled interrupt source activates the INT pin, an external host reads the flags registers to determine the cause. Remember that all flags are cleared when the register is read. If the INT pin is programmed for Level mode, then the condition clears and the INT pin returns to its inactive state. If the pin is programmed for pulse mode, then reading the flag also clears the flag and the pin. The pulse does not complete its specified duration if the flags register is read. If the INT pin is used as a host reset, the flags register is not read during a reset.

#### Flags Register

The flags register has three flag bits: WDF, AF, and PF, which can be used to generate an interrupt. These flags are set by the watchdog timeout, alarm match, or power fail monitor respectively. The processor can either poll this register or enable interrupts to be informed when a flag is set. These flags are automatically reset when the register is read. The flags register is automatically loaded with the value 0x00 on power-up (except for the OSCF bit. See Stopping and Starting the Oscillator on page 16).



#### Accessing the Real Time Clock through SPI

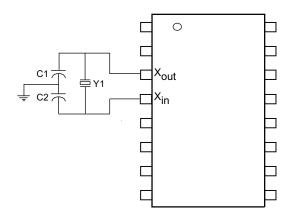
CY14B101P uses 16 registers for RTC. These registers can be read out or written to by accessing all 16 registers in burst mode or accessing each register, one at a time. The RDRTC and WRTC instructions are used to access the RTC.

All the RTC registers can be read in burst mode by issuing the RDRTC instruction and reading all 16 bytes without bringing the CS pin HIGH. The 'R' bit must be set while reading the RTC

timekeeping registers to ensure that transitional values of time are not read.

Writes to the RTC register are performed using the WRTC instruction. Writing RTC timekeeping registers and control registers, except for the flag register needs the 'W' bit of the flag register to be set to '1'. The internal counters are updated with the new date and time setting when the 'W' bit is cleared to '0'. All the RTC registers can also be written in burst mode using the WRTC instruction.

Figure 22. RTC Recommended Component Configuration [2]



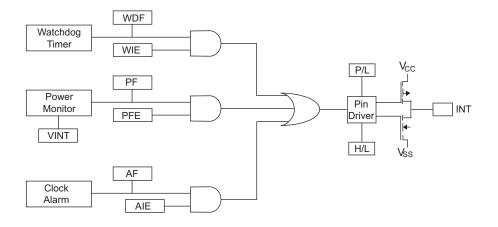
#### **Recommended Values**

Y1 = 32.768 kHz (12.5 pF) $C_1 = 10 \text{ pF}$ 

 $C_2 = 67 \text{ pF}$ 

Note: The recommended values for C1 and C2 include board trace capacitance.

Figure 23. Interrupt Block Diagram



WDF - Watchdog Timer Flag

WIE - Watchdog Interrupt

Enable

PF - Power Fail Flag

PFE - Power Fail Enable

AF - Alarm Flag

AIE - Alarm Interrupt Enable

P / L - Pulse Level

H / L - High / Low

#### Not

<sup>2.</sup> For nonvolatile static random access memory (nvSRAM) real time clock (RTC) design guidelines and best practices, see application note AN61546.



Table 8. RTC Register Map [3, 4]

Dogiotor		BCD Format Data							Function/Dongs
Register	D7	D6	D5	D4	D3	D2	D1	D0	Function/Range
0x0F		10s y	/ears			Yea	ars		Years: 00-99
0x0E	0	0	0	10s months		Mor	nths		Months: 01–12
0x0D	0	0	10s day	of month		Day of	month		Day of month: 01-31
0x0C	0	0	0	0	0		Day of wee	k	Day of week: 01–07
0x0B	0	0	10s l	nours	Hours				Hours: 00-23
0x0A	0	1	0s minute:	S	Minutes				Minutes: 00-59
0x09	0	1	10s seconds			Seco	Seconds: 00-59		
0x08	OSCEN (0)	0	Cal sign (0)		Calibration (00000)				Calibration values <sup>[5]</sup>
0x07	WDS (0)	WDW (0)			WDT (0	000000)			Watchdog <sup>[5]</sup>
0x06	WIE (0)	AIE (0)	PFE (0)	0	H/L (1)	P/L (0)	0	0	Interrupts <sup>[5]</sup>
0x05	M (1)	0	10s ala	rm date		Alarn	n day		Alarm, day of month: 01-31
0x04	M (1)	0	10s alarm hours			Alarm hours			Alarm, hours: 00-23
0x03	M (1)	10s	alarm min	utes	Alarm minutes				Alarm, minutes: 00-59
0x02	M (1)	10s	alarm seco	onds	Alarm seconds				Alarm, seconds: 00-59
0x01		10s ce	nturies			Cent	uries		Centuries: 00-99
0x00	WDF	AF	PF	OSCF <sup>[6]</sup>	0	CAL (0)	W (0)	R (0)	Flags <sup>[5]</sup>

- Notes
  3. () designates values shipped from the factory.
  4. The unused bits of RTC registers are reserved for future use and should be set to '0' 5. This is a binary value, not a BCD value.
  6. When user resets OSCF flag bit, the flags register will be updated after t<sub>RTCp</sub> time.



Table 9. Register Map Detail

				Time Keepii	ng - Years								
	D7	D6	D5	D4	D3	D2	D1	D0					
0x0F	10s years Years												
	Contains the lower two BCD digits of the year. Lower nibble (four bits) contains the value for years; upper nibble (four bits) contains the value for 10s of years. Each nibble operates from 0 to 9. The range for the register is 0–99.												
	Time Keeping - Months												
0x0E	D7	D6	D5	D4	D3	D2	D1	D0					
	0 0 10s month Months												
	Contains the nibble (one b	BCD digits of the	ne month. Lower upper digit and	nibble (four bits operates from 0	s) contains the to 1. The ran	e lower digit a	nd operates fror gister is 1–12.	n 0 to 9; upp					
				Time Keepi	ng - Date								
	D7	D6	D5	D4	D3	D2	D1	D0					
0x0D	0	0	10s day	of month		Day	of month						
	to 9; upper ni		contains the 10s				ower digit and o for the register i						
				Time Keep	ing - Day								
	D7	D6	D5	D4	D3	D2	D1	D0					
0x0C	0	0	0	0	0		Day of week						
	Lower nibble (three bits) contains a value that correlates to day of the week. Day of the week is a ring counter that counts from 1 to 7 then returns to 1. The user must assign meaning to the day value, because the day is not integrated with the date.												
				Time Keepir									
	D7	D6	D5	D4	D3	D2	D1	D0					
0x0B	0	0	10s h				Hours						
				pper digit and o	perates from (		e lower digit and nge for the regis						
				Time Keepin		_							
	D7	D6	D5	D4	D3	D2	D1	D0					
0x0A	0		10s minutes				inutes						
	Contains the BCD value of minutes. Lower nibble (four bits) contains the lower digit and operates from 0 to 9; upper												
	nibble (three bits) contains the upper minutes digit and operates from 0 to 5. The range for the register is 0–59.  Time Keeping - Seconds												
	D7	D6	D5	D4	D3	D2	D1	D0					
0x09	0	D0	10s seconds	D4	D3		econds						
CACC		PCD value of a		nibble (four bite)	Contains the		nd operates from	0 to 0: upp					
							register is 0–59.	o to 9, uppe					
	,	,	- 11 3	Calibration									
0.00	D7	D6	D5	D4	D3	D2	D1	D0					
0X08	OSCEN	0	Calibration			Calibration							
			sign										
OSCEN					When set to '0	', the oscillate	or runs. Disablin	g the oscillat					
	saves battery or capacitor power during storage.  Determines if the calibration adjustment is applied as an addition (1) to or as a subtraction (0) from the time-base.												
alibration sign	Determines if	the calibration	adjustment is a	pplied as an ad	dition (1) to or	as a subtrac	tion (0) from the	time-base.					



Table 9. Register Map Detail (continued)

				WatchDo	og Timer			
0x07	D7	D6	D5	D4	D3	D2	D1	D0
	WDS	WDW		•	WE	)T		
WDS		obe. Setting thi automatically a						
WDW	the user to se	ite enable. Setti et the watchdog the watchdog re mer on page 17	strobe bit withough	out disturbing th	e timeout value	e. Setting this b	oit to '0' allows b	oits D5 – D0
WDT	multiplier of to of 3 Fh). Sett	neout selection. he 32 Hz count ing the watchdo previous cycle.	(31.25 ms). Th og timer register	e range of time	out value is 31	.25 ms (a setti	ng of 1) to 2 se	conds (setti
				Interrupt Sta	atus/Control			
0x06	D7	D6	D5	D4	D3	D2	D1	D0
	WIE	AIE	PFE	0	H/L	P/L	0	0
WIE		errupt enable. V . When set to '0					g timer drives tl	ne INT pin a
AIE		pt enable. Whe ffects the AF fla		alarm match dr	ives the INT pir	n and the AF fl	ag. When set to	o '0', the ala
PFE		able. When set ts only the PF f		n match drives	the INT pin and	d the PF flag. \	When set to '0',	the power
0	Reserved for	future use						
H/L	HIGH / LOW.	When set to '1'	, the INT pin is	driven active H	IGH. When set	to '0', the INT	pin is open drai	in, active LC
P/L		. When set to '1' en set to 0, the I		n to an active le	vel (as set by l			
				Alarm	ı - Day			
0x05	D7	D6	D5	D4	D3	D2	D1	D0
UXUU	М	0	10s ala	ırm date		Alar	m date	
	Contains the	alarm value for	the date of the	month and the	mask bit to se	lect or deseled	t the date value	
	N.A. ( 1 N.A.()							Э.
M	to ignore the	this bit is set to date value.	0, the date valu		alarm match.	Setting this bit	to '1' causes th	
M			0, the date valu			Setting this bit	to '1' causes th	
			0, the date value		alarm match.	Setting this bit	to '1' causes th	
	to ignore the	date value.	D5	Alarm	alarm match.	D2		e match circ
0x04	to ignore the  D7  M	date value.	<b>D5</b> 10s alai	Alarm D4	Hours D3	<b>D2</b> Alarr	D1 n hours	e match circ
	D7 M Contains the Match. When	D6 0	D5 10s alar the hours and o '0', the hours	Alarm D4 rm hours the mask bit to	- Hours D3 select or desel	D2 Alarr	D1 n hours value.	e match circ
0x04	D7 M Contains the Match. When	D6 0 alarm value for	D5 10s alar the hours and o '0', the hours	Alarm D4 rm hours the mask bit to value is used in	- Hours D3 select or desel	D2 Alarr	D1 n hours value.	e match circ
<b>0x04</b>	D7 M Contains the Match. When	D6 0 alarm value for	D5 10s alar the hours and o '0', the hours	Alarm D4 rm hours the mask bit to value is used in	Hours D3 select or desel	D2 Alarr	D1 n hours value.	e match circ
<b>0x04</b>	D7  M Contains the  Match. When circuit to ignore	D6 0 alarm value for this bit is set to the hours value	D5 10s alar the hours and o '0', the hours	Alarm D4 rm hours the mask bit to value is used in  Alarm - D4	- Hours D3 select or deselect or deselect or matemates	D2 Alarr lect the hours ch. Setting this	D1 n hours value. s bit to '1' cause	D0
0x04	D7 M Contains the Match. When circuit to ignore	D6 0 alarm value for this bit is set to the hours value	D5  10s alar the hours and o '0', the hours alue.  D5  0s alarm minut	Alarm D4 rm hours the mask bit to value is used ir  Alarm -  D4 es	e alarm match. S  Hours  D3  select or desel the alarm mat  Minutes  D3	D2 Alarred the hours of the ch. Setting this ch. Setting this ch. D2 Alarm	D1 n hours value. s bit to '1' cause  D1 minutes	D0



Table 9. Register Map Detail (continued)

				Alarm - S	econds			
	D7	D6	D5	D4	D3	D2	D1	D0
0x02	М	1	0s alarm secon	ds		Alarm	seconds	
	Contains the	alarm value for	the seconds ar	nd the mask bit	o select or de	select the seco	nds' value.	
М		this bit is set to		s value is used i	n the alarm m	atch. Setting th	is bit to 1 caus	ses the match
				Time Keeping	- Centuries			
0x01	D7	D6	D5	D4	D3	D2	D1	D0
		10s c	enturies	I		Cen	turies	
	Contains the contains the	BCD value of our composite upper digit and	centuries. Lower operates from (	nibble contains to 9. The rang	the lower digite for the regist	t and operates er is 0-99 cent	from 0 to 9; u uries.	pper nibble
				Fla	gs			
0x00	D7	D6	D5	D4	D3	D2	D1	D0
	WDF	AF	PF	OSCF	0	CAL	W	R
WDF				et to '1' when the s register is read			o reach 0 with	out being res
AF				en the time and ags register is re			d in the alarm	registers with
PF	Power fail fla '0' when the f	g. This read on flags register is	ly bit is set to '1 read or on pow	' when power fa er-up.	lls below the p	ower fail thres	hold V <sub>SWITCH</sub> .	It is cleared
OSCF	indicates that cleared interr	RTC backup ponally by the chip	ower failed and	he oscillator is e clock value is no it check for this RTCp time.	longer valid. T	his bit survives	the power cyc	le and is nev
CAL	Calibration m	ode. When set ation. This bit de	to '1', a 512 Hz efaults to 0 (disa	square wave is on bled) on power	output on the II	NT pin. When s	set to '0', the IN	IT pin resume
W	alarm registe the RTC regis	rs, calibration resters to be tran	egister, interrup sferred to the ti	es updates of the t register and fla me keeping cou on power-up.	gs register. Se	etting the 'W' bi	t to '0' causes	the contents
R	t <sub>RTCp</sub> time to complete. This bit defaults to 0 on power-up.  Read enable: Setting 'R' bit to '1', stops clock updates to user RTC registers so that clock updates are not seen during the reading process. Set 'R' bit to '0' to resume clock updates to the holding register. Setting this bit does not require 'W' bit to be set to '1'. This bit defaults to 0 on power-up.							



### **Maximum Ratings**

Exceeding maximum ratings may shorten the useful life of the device. These user guidelines are not tested. Maximum accumulated storage time At 150 °C ambient temperature ...... 1000 h At 85 °C ambient temperature ...... 20 Years Maximum junction temperature ...... 150 °C Supply voltage on  $V_{CC}$  relative to  $V_{SS}$  ......-0.5 V to +4.1 V DC voltage applied to outputs in High Z state ......–0.5 V to  $V_{CC}$  + 0.5 V Input voltage ......–0.5 V to  $V_{CC}$  + 0.5 V

Transient voltage (< 20 ns) on any pin to ground potential–2.0 V to $V_{\rm CC}$ + 2.0 V
Package power dissipation capability ( $T_A = 25  ^{\circ}\text{C}$ )
Surface mount lead soldering temperature (3 Seconds)+260 °C
DC output current (1 output at a time, 1s duration) 15 mA $$
Static discharge voltage (per MIL-STD-883, Method 3015)
Latch up current > 200 mA

### **Operating Range**

Range	Range Ambient Temperature	
Industrial	−40 °C to +85 °C	2.7 V to 3.6 V

#### DC Electrical Characteristics

#### Over the Operating Range

Parameter	Description	Test Conditions	Min	<b>Typ</b> <sup>[7]</sup>	Max	Unit
V <sub>CC</sub>	Power supply voltage		2.7	3.0	3.6	V
I <sub>CC1</sub>	Average V <sub>cc</sub> current	At f <sub>SCK</sub> = 40 MHz. Values obtained without output loads (I <sub>OUT</sub> = 0 mA)	-	_	10	mA
I <sub>CC2</sub>	Average V <sub>CC</sub> current during STORE	All inputs don't care, V <sub>CC</sub> = Max. Average current for duration t <sub>STORE</sub>	-	_	10	mA
I <sub>CC4</sub>	Average V <sub>CAP</sub> current during AutoStore cycle	All inputs don't care. Average current for duration tstore	_	_	5	mA
I <sub>SB</sub>	V <sub>CC</sub> standby current	$CS \ge (V_{CC} - 0.2 \text{ V})$ . $V_{IN} \le 0.2 \text{ V}$ or $\ge (V_{CC} - 0.2 \text{ V})$ . W bit set to '0'. Standby current level after nonvolatile cycle is complete. Inputs are static. f = 0 MHz.	_	_	5	mA
I <sub>IX</sub> <sup>[8]</sup>	Input leakage current (except HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$	<b>-1</b>	_	+1	μΑ
	Input leakage current (for HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$	-100	_	+1	μΑ
I <sub>OZ</sub>	Off state output leakage current	$V_{CC} = Max, V_{SS} \le V_{OUT} \le V_{CC}$	-1	_	+1	μΑ
V <sub>IH</sub>	Input HIGH voltage		2.0	-	$V_{CC} + 0.5$	V
V <sub>IL</sub>	Input LOW voltage		V <sub>SS</sub> – 0.5	-	0.8	V
V <sub>OH</sub>	Output HIGH voltage	$I_{OUT} = -2 \text{ mA}$	2.4	-	_	V
V <sub>OL</sub>	Output LOW voltage	I <sub>OUT</sub> = 4 mA	_	_	0.4	V
V <sub>CAP</sub> <sup>[9]</sup>	Storage capacitor	Between V <sub>CAP</sub> pin and V <sub>SS</sub>	61	68	180	μF
V <sub>VCAP</sub> <sup>[10, 11]</sup>	Maximum voltage driven on V <sub>CAP</sub> pin by the device	V <sub>CC</sub> = Max	_	-	V <sub>CC</sub>	٧

#### Notes

- Typi<u>cal values</u> are at 25 °C, V<sub>CC</sub>= V<sub>CC(Typ)</sub>. Not 100% tested.
   The HSB pin has I<sub>OUT</sub> = -2 uA for V<sub>OH</sub> of 2.4 V when both active HIGH and LOW drivers are disabled. When they are enabled standard V<sub>OH</sub> and V<sub>OL</sub> are valid. This parameter is characterized but not tested.

Min V<sub>CAP</sub> value guarantees that there is a sufficient charge available to complete a successful AutoStore operation. Max V<sub>CAP</sub> value guarantees that the capacitor on V<sub>CAP</sub> is charged to a minimum voltage during a Power-Up RECALL cycle so that an immediate power-down cycle can complete a successful AutoStore. Therefore it is always recommended to use a capacitor within the specified min and max limits. See application note AN43593 for more details on V<sub>CAP</sub> options.

Maximum voltage on V<sub>CAP</sub> pin (V<sub>VCAP</sub>) is provided for guidance when choosing the V<sub>CAP</sub> capacitor. The voltage rating of the V<sub>CAP</sub> capacitor across the operating temperature range should be higher than the V<sub>VCAP</sub> voltage.

<sup>11.</sup> These parameters are guaranteed by design and are not tested.



### **Data Retention and Endurance**

### Over the Operating Range

Parameter	Description	Min	Unit
DATA <sub>R</sub>	Data retention	20	Years
$NV_C$	Nonvolatile STORE operations	1,000	K

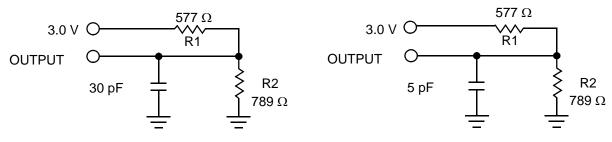
### Capacitance

Parameter [12]	Description	Test Conditions	Max	Unit
C <sub>IN</sub>	Input capacitance	$T_A = 25 ^{\circ}\text{C}, f = 1 \text{MHz},$	6	pF
C <sub>OUT</sub>	Output pin capacitance	$V_{CC} = V_{CC}$ (Typ)	8	pF

### **Thermal Resistance**

Parameter [12]	Description	Test Conditions	16-pin SOIC	Unit
$\theta_{JA}$	0	Test conditions follow standard test methods and procedures for measuring thermal	55.17	°C / W
$\theta$ JC	Thermal resistance (junction to case)	impedance, per EIA / JESD51.	2.64	° C / W

Figure 24. AC Test Loads and Waveforms



### **AC Test Conditions**

Input pulse levels	. 0 V to 3 V
Input rise and fall times (10%–90%)	<u>&lt;</u> 3 ns
Input and output timing reference levels	1.5 V

#### Note

Document Number: 001-44109 Rev. \*M

<sup>12.</sup> These parameters are guaranteed by design and are not tested.



#### **RTC Characteristics**

Over the Operating Range

Parameter	Description		Min	<b>Typ</b> <sup>[13]</sup>	Max	Units
V <sub>RTCbat</sub>	RTC battery pin voltage		1.8	3.0	3.6	V
I <sub>BAK</sub> <sup>[14]</sup>	RTC backup current	T <sub>A</sub> (min)	_	_	0.35	μΑ
		25 °C	_	0.35	-	μΑ
		T <sub>A</sub> (max)	_	_	0.5	μΑ
V <sub>RTCcap</sub> <sup>[15]</sup>	RTC capacitor pin voltage	T <sub>A</sub> (min)	1.6	_	3.6	V
		25 ℃	1.5	3.0	3.6	V
		T <sub>A</sub> (max)	1.4		3.6	V
t <sub>RTCp</sub>	RTC processing time from end of 'W' bit set to '0'		_	_	350	μs
tOCS	RTC oscillator time to start		_	1	2	sec
R <sub>BKCHG</sub>	RTC backup capacitor charge current-limiting resistor		350	_	850	Ω

### **AC Switching Characteristics**

Over the Operating Range

Parar	meters <sup>[16]</sup>	Description  Clack frequency, SCK	40	MHz	25 (RDRTC Ins	Unit	
Cypress Parameter	Alt. Parameter		Min	Max	Min	Max	Oilit
f <sub>SCK</sub>	f <sub>SCK</sub>	Clock frequency, SCK	-	40	_	25	MHz
t <sub>CL</sub>	t <sub>WL</sub>	Clock pulse width LOW	11	_	18	_	ns
t <sub>CH</sub>	t <sub>WH</sub>	Clock pulse width HIGH	11	_	18	_	ns
t <sub>CS</sub>	t <sub>CE</sub>	CS HIGH time	20	_	20	_	ns
t <sub>CSS</sub>	t <sub>CES</sub>	CS setup time	10	_	10	_	ns
t <sub>CSH</sub>	t <sub>CEH</sub>	CS hold time	10	_	10	_	ns
t <sub>SD</sub>	t <sub>SU</sub>	Data in setup time	5	_	5	_	ns
t <sub>HD</sub>	t <sub>H</sub>	Data in hold time	5	-	5	-	ns
t <sub>HH</sub>	t <sub>HD</sub>	HOLD hold time	5	-	5	-	ns
t <sub>SH</sub>	t <sub>CD</sub>	HOLD setup time	5	_	5	_	ns
t <sub>CO</sub>	t <sub>V</sub>	Output valid	_	9	_	15	ns
t <sub>HHZ</sub> <sup>[18]</sup>	t <sub>HZ</sub>	HOLD to output HIGH-Z	_	15	_	15	ns
tH <sub>LZ</sub> <sup>[18]</sup>	$t_{LZ}$	HOLD to output LOW-Z	-	15	_	15	ns
t <sub>OH</sub>	t <sub>HO</sub>	Output hold time	0	_	0	_	ns
t <sub>HZCS</sub>	t <sub>DIS</sub>	Output disable time	-	25	_	25	ns

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<sup>13.</sup> Typical values are at 25 °C, V CC = V<sub>CC(Typ)</sub>. Not 100% tested.

14. Current drawn from either V<sub>RTCcap</sub> or V<sub>RTCbat</sub> when V<sub>CC</sub> < V<sub>SWITCH</sub>.

15. If V<sub>RTCcap</sub> > 0.5 V or if no capacitor is connected to V<sub>RTCcap</sub> pin, the oscillator will start in tOCS time. If a backup capacitor is connected and V<sub>RTCcap</sub> < 0.5 V, the capacitor must be allowed to charge to 0.5 V for oscillator to start.

16. Test conditions assume signal transition time of 3 ns or less, timing reference levels of V<sub>CC</sub>/2, input pulse levels of 0 to V<sub>CC(typ)</sub>, and output loading of the specified I<sub>OL</sub>/I<sub>OH</sub> and load capacitance shown in Figure 24.

17. Applicable for RTC opcode cycles, address cycles and dataout cycles.

<sup>18.</sup> These parameters are guaranteed by design and are not tested.



### **Switching Waveforms**

Figure 25. Synchronous Data Timing (Mode 0)

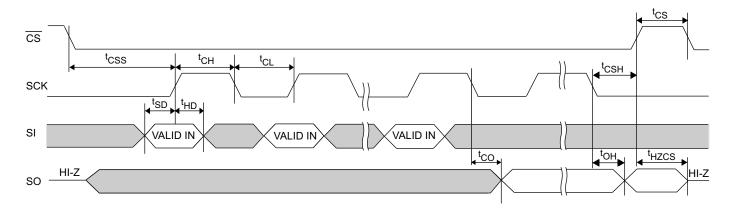
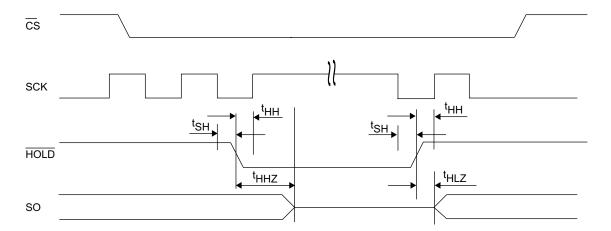


Figure 26. HOLD Timing





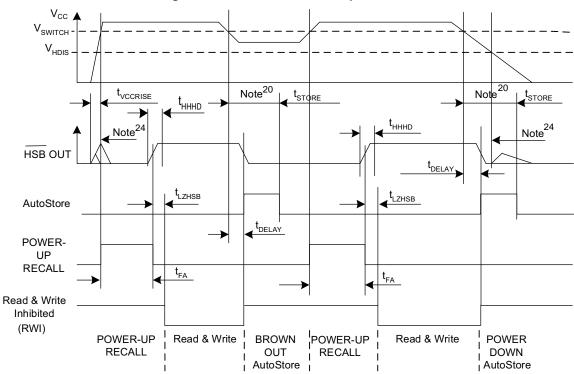
### **AutoStore or Power-Up RECALL**

Over the Operating Range

Doromotor	Decembries	CY14B101P		Unit
Parameter	Description	Min	Max	Unit
t <sub>FA</sub> <sup>[19]</sup>	Power-Up RECALL duration	_	20	ms
t <sub>STORE</sub> [20]	STORE cycle duration	_	8	ms
t <sub>DELAY</sub> [21]	Time allowed to complete SRAM write cycle	_	25	ns
V <sub>SWITCH</sub>	Low voltage trigger level	_	2.65	V
t <sub>VCCRISE</sub> <sup>[22]</sup>	V <sub>CC</sub> rise time	150	-	μs
V <sub>HDIS</sub> <sup>[22]</sup>	HSB output disable voltage	_	1.9	V
t <sub>LZHSB</sub> <sup>[22]</sup>	HSB high to nvSRAM active time	_	5	μs
t <sub>HHHD</sub> <sup>[22]</sup>	HSB High active time	-	500	ns

### **Switching Waveforms**

Figure 27. AutoStore or Power-Up RECALL [23]



- 19. t<sub>FA</sub> starts from the time V<sub>CC</sub> rises above V<sub>SWITCH</sub>.
  20. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware STORE takes place.
  21. On a Hardware STORE and AutoStore initiation, SRAM write operation continues to be enabled for time t<sub>DELAY</sub>.
  22. These parameters are guaranteed by design and are not tested.
  23. Read and Write cycles are ignored during STORE, RECALL, and while V<sub>CC</sub> is below V<sub>SWITCH</sub>.
  24. During power-up and power-down, HSB glitches when HSB pin is pulled up through an external resistor.



### **Software Controlled STORE/RECALL Cycles**

Over the Operating Range

Parameter	Description	CY14I	Unit	
Parameter	Description	Min	Min Max	Oilit
t <sub>RECALL</sub>	RECALL duration	_	200	μs
t <sub>SS</sub> <sup>[25, 26]</sup>	Soft sequence processing time	_	100	μs

### **Switching Waveforms**

Figure 28. Software STORE Cycle [26]

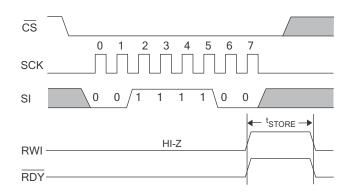


Figure 29. Software RECALL Cycle [26]

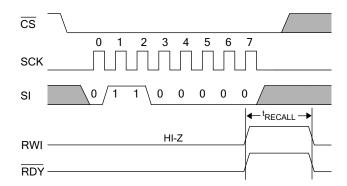


Figure 30. AutoStore Enable Cycle

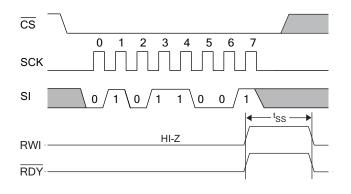
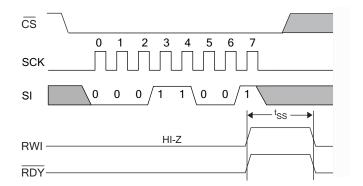


Figure 31. AutoStore Disable Cycle



#### Notes

<sup>25.</sup> This is the amount of time it takes to take action on a soft sequence command. Vcc power must remain HIGH to effectively register command. 26. Commands such as STORE and RECALL lock out /IO until operation is complete which further increases this time. See the specific command.



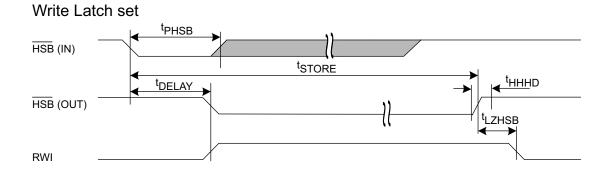
# **Hardware STORE Cycle**

Over the Operating Range

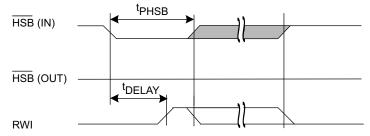
Parameter	Description	CY14E	CY14B101P		
	Description	Min Max			
t <sub>PHSB</sub>	Hardware STORE pulse width	15	1	ns	

### **Switching Waveforms**

Figure 32. Hardware STORE Cycle [27]



### Write Latch not set



 $\overline{\text{HSB}}$  pin is driven HIGH to V<sub>CC</sub> only by Internal 100 K $\Omega$  resistor, HSB driver is disabled SRAM is disabled as long as HSB (IN) is driven LOW.

#### Note

27. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware STORE takes place.

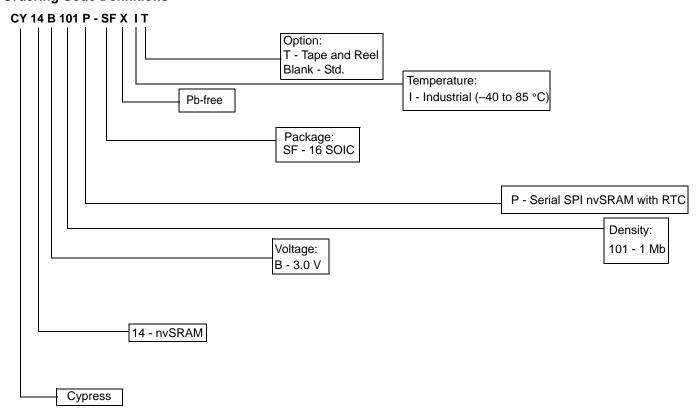


### **Ordering Information**

Ordering Code	Package Diagram	Package Type	Operating Range
CY14B101P-SFXI	51-85022	16-pin SOIC	Industrial
CY14B101P-SFXIT			

The above part is Pb-free.

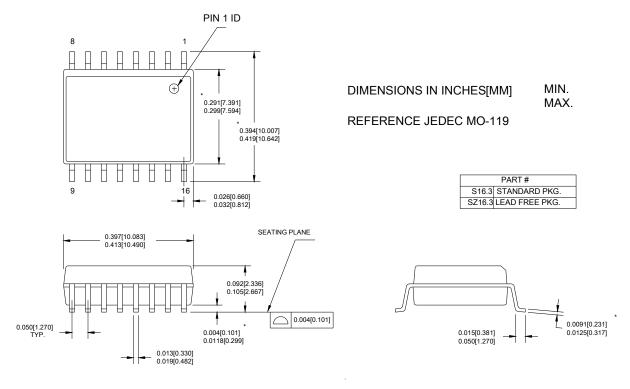
### **Ordering Code Definitions**





### **Package Diagram**

Figure 33. 16-pin SOIC (0.413 × 0.299 × 0.0932 inches) Package Outline, 51-85022





### **Acronyms**

Acronym	Description
BCD	binary coded decimal
СРНА	clock phase
CPOL	clock polarity
EEPROM	electrically erasable programmable read-only memory
EIA	electronic industries alliance
I/O	input/output
JEDEC	joint electron devices engineering council
LSB	least significant bit
MSB	most significant bit
nvSRAM non-volatile static random access memory	
OSCF oscillator fail flag	
RWI	read and write inhibit
RTC	real time clock
RoHS	restriction of hazardous substances
SPI	serial peripheral interface
SONOS	silicon-oxide-nitride-oxide semiconductor
SOIC	small outline integrated circuit
SRAM	static random access memory

### **Document Conventions**

### **Units of Measure**

Symbol	Unit of Measure			
$\mathcal{C}$	degree Celsius			
F	farad			
Hz	hertz			
kHz	kilohertz			
kΩ	kilohm			
MHz	megahertz			
μΑ	microampere			
mA	milliampere			
μF	microfarad			
μS	microsecond			
ms	millisecond			
ns	nanosecond			
Ω	ohm			
%	percent			
pF	picofarad			
ppm	parts per million			
sec	second			
V	volt			
W	watt			



# **Document History Page**

Occument Number: 001-44109				
Rev.	ECN	Orig. of Change	Submission Date	Description of Change
**	1939467	UNC / AESA	01/16/2008	New data sheet.
*A	2607447	GSIN / GVCH / AESA	11/21/2008	Updated the "Feature" section, Clock rate changed from 40 MHz to 25 MH Updated nvSRAM STORE, RECALL, AutoStore Enable/Disable sections Removed Soft Sequence, added SPI instructions for STORE, RECALL, toStore Enable and Disable, Updated SPI with following changes: Added more information for protocol Added four new SPI instruction WEN bit cleared on CS going HIGH edge after Write instructions and fo nvSRAM special instructions Added RDY bit to Status Register for indicating Store/Recall in progress Added READ RTC and WRITE RTC instructions. Changed RTC recommended configuration values. Updated tOCS values for normal and room temperature Other changes as per new EROS Removed 8 SOIC package Added two new 8DFN packages Changed tCO parameter to 9 ns Updated data sheet template Replaced CY14B101P with CY14B101PA. Changed title to "CY14B101PA 1Mbit (128K x 8) Serial SPI nvSRAM with al-Time-Clock"
*B	2654487	GVCH / GSIN / PYRS	02/04/2009	Moved from Advance information to Preliminary Changed part number from CY14B101PA to CY14B101P Changed $X_1$ , $X_2$ pin names to $X_{\text{out}}$ , $X_{\text{in}}$ respectively Updated pin description of $V_{\text{CAP}}$ pin Updated Device operation and SPI peripheral interface description Added Factory setting values for BP1, BP2 and WPEN bits Updated Real Time Clock operation description Added footnote 2 Added default values to RTC Register Map" table 8 Added footnote 3 Updated flag register description in Register Map Detail" table 9 Changed C1, C2 values to 21pF, 21pF respectively Changed $I_{\text{CC2}}$ from 5 mA to 10 mA Changed $I_{\text{BAK}}$ value from 350 nA to 450 nA at hot temperature Changed $V_{\text{RTCcap}}$ typical value from 2.4V to 3.0V
*C	2733293	GVCH	07/08/2009	Added note in AutoStore Operation description Changed C1, C2 values from 21pF, 21pF to 10pF, 67pF respectively Added best practices Updated test condition of I <sub>CC1</sub> and I <sub>SB</sub> Updated I <sub>BAK</sub> and V <sub>RTCcap</sub> parameter values Added R <sub>BKCHG</sub> parameter to RTC characteristics table Updated V <sub>HDIS</sub> and t <sub>DELAY</sub> parameter description
*D	2757375	GVCH	08/28/2009	Moved data sheet status from preliminary to Final Removed commercial temperature related specs Added thermal resistance values for 16-SOIC package Added note to Write Sequence (WRITE) description Changed $V_{RTCbat}$ max value from 3.3V to 3.6V Changed $R_{BKCHG}$ min value from $450\Omega$ to $350\Omega$ Updated footnote 8



# **Document History Page** (continued)

	Number: 00	0rig. of	Submission	
Rev.	ECN	Change	Date	Description of Change
*E	2767333	GVCH	09/22/2009	Changed STORE cycles to QuantumTrap from 200K to 1 Million Updated Figure 2 Updated I <sub>BAK</sub> RTC backup current spec unit from nA to μA Added Contents on page 2.
*F	2893734	GVCH	03/17/10	Removed inactive part from Ordering Information table. Updated links in Sales, Solutions, and Legal Information. Updated Package Diagram.
*G	2923525	GVCH	04/27/10	Table 1: Added more clarity on HSB pin operation Hardware STORE and HSB Pin Operation: Added more clarity on HSB pin operation Power-On Reset: Added status of bits 4-6 Updated Power-Down description Table 3: Added definition of bits 4-6 Updated Figure 25, Figure 26, and Figure 27 Updated footnote 18 Removed t <sub>DHSB</sub> parameter Updated Figure 32
*H	3036842	GVCH	10/09/10	Changed ground naming convention from GND to V <sub>SS</sub> Updated Power-Down description Power-On Reset: Added status of bits 4-6 Table 3: Added definition of bits 4-6 Updated Figure 7 Updated HOLD Pin Operation, Figure 20 and Figure 26 to indicate that CS pir must remain LOW along with HOLD pin to pause serial communication Added footnote 4 Added Figure 30 and Figure 31 Added Acronyms and Document Conventions.
*	3134300	GVCH	01/11/11	Hardware STORE and HSB Pin Operation: Added more clarity on HSB pin operation Updated Setting the Clock description Added footnote 4 Updated 'W' bit description in Register Map Detail table Updated best practices Added t <sub>RTCp</sub> parameter to RTC Characteristics table Updated t <sub>LZHSB</sub> parameter description
*J	3150308	GVCH	01/21/11	No technical updates
*K	3320877	GVCH	07/19/11	Added footnote 9 and 16
*L	3498838	GVCH	01/24/2012	Added footnote 1 and 2 Updated Ordering Information: Added CY14B101P-SFXIT part number Updated Package Diagram
*M	3665165	GVCH	08/03/2012	Updated Real Time Clock Operation (description). Updated Maximum Ratings (Changed "Ambient temperature with power applied" to "Maximum junction temperature"). Updated DC Electrical Characteristics (Added V <sub>VCAP</sub> parameter and its details added Note 10 and referred the same note in V <sub>VCAP</sub> parameter, also referred Note 11 in V <sub>VCAP</sub> parameter).



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